

<b>Notice of References Cited</b>	Application/Control No. 10/561,211	Applicant(s)/Patent Under Reexamination KITAHARA ET AL.	
	Examiner Bruck Kifle, Ph.D.	Art Unit 1624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,372,735	04-2002	Ohtsuka et al.	514/212.06
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	D	US-			
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**NON-PATENT DOCUMENTS**

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